

**Search Notes**

Application/Control No.

10/681,729

Examiner

Richard K. Lee

Applicant(s)/Patent under  
Reexamination

TERHUNE ET AL.

Art Unit

2832

**SEARCHED**

Class	Subclass	Date	Examiner
200	51R	10/3/2005	KL
439	6-9		
↓	188	↓	↓

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST print out.	10/3/2005	KL